









SN54HC138, SN74HC138 SCLS107G - DECEMBER 1982 - REVISED OCTOBER 2021

SNx4HC138 3-Line To 8-Line Decoders/Demultiplexers

1 Features

- Targeted Specifically for High-Speed Memory **Decoders and Data-Transmission Systems**
- Wide Operating Voltage Range (2 V to 6 V)
- Outputs Can Drive Up To 10 LSTTL Loads
- Low Power Consumption, 80-µA Maximum I_{CC}
- Typical t_{pd} = 15 ns
- ±4-mA Output Drive at 5 V
- Low Input Current of 1-uA Maximum
- Active Low Outputs (Selected Output is Low)
- Incorporate Three Enable Inputs to Simplify Cascading or Data Reception

2 Applications

- LED Displays
- Servers
- White Goods
- Power Infrastructure
- **Building Automation**
- **Factory Automation**

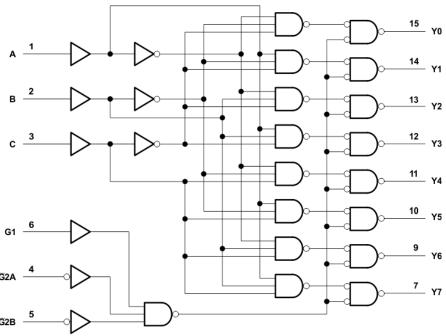
3 Description

The SNx4HC138 devices are designed to be used in high-performance memory-decoding or data-routing applications requiring very short propagation delay times. In high-performance memory systems, these decoders can be used to minimize the effects of system decoding. When employed with high-speed memories using a fast enable circuit, the delay times of these decoders and the enable time of the memory are usually less than the typical access time of the memory. This means that the effective system delay introduced by the decoders is negligible.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
SN74HC138D	SOIC (16)	9.90 mm x 3.90 mm
SN74HC138DB	SSOP (16)	6.20 mm x 5.30 mm
SN74HC138N	PDIP (16)	19.32 mm x 6.35 mm
SN74HC138NS	SO (16)	10.20 mm x 5.30 mm
SN74HC138PW	TSSOP (16)	5.00 mm x 4.40 mm
SN54HC138J	CDIP (16)	21.34 mm x 6.92 mm
SN54HC138W	CFP (16)	10.16 mm x 6.73 mm
SN54HC138FK	LCCC (20)	8.89 mm x 8.89 mm

For all available packages, see the orderable addendum at the end of the data sheet.



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Pin numbers shown are for the D, DB, J, N, NS, PW, and W packages.

Functional Block Dlagram



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4 Revision History NOTE: Page numbers for previous revisions	may differ fr	om page numbers in the current version.	
Changes from Revision E (September 200	3) to Revisi	on F (September 2016)	Page
 Added ESD Ratings table, Feature Descri Implementation section, Power Supply Re 		n, Device Functional Modes, Application and tions section, Layout section, Device and	

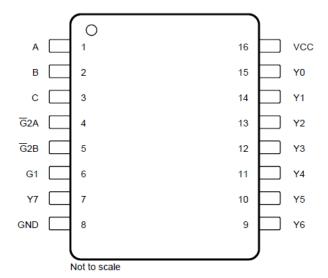
Changed R_{0,JA} values from 73 to 87.3 (D), from 82 to 104.3 (DB), from 67 to 54.8 (N), from 64 to 91.1 (NS), and from 108 to 114.6 (PW)......5

Changes from Revision F (September 2016) to Revision G (October 2021)

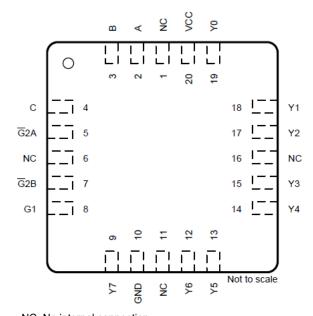
Page



5 Pin Configuration and Functions



SOIC, SSOP, PDIP, SO, TSSOP, CDIP, or CFP Package 16-Pin D, DB, N, NS, PW, J or W Top View



NC: No internal connection

LCCC Package

20-Pin FK

Top View

Pin Functions

	PIN			
NAME	SOIC, SSOP, PDIP, SO, TSSOP, CDIP, CFP	LCCC	I/O ⁽¹⁾	DESCRIPTION
A	1	2	I	Select input A (least significant bit)
В	2	3	I	Select input B
С	3	4	I	Select input C (most significant bit)
G2A	4	5	I	Active low enable A
G2B	5	7	I	Active low enable B
G1	6	8	ı	Active high enable
GND	8	10	_	Ground
NC	_	1, 6, 11, 16	_	No internal connection
V _{CC}	16	20	_	Supply voltage
Y0	15	19	0	Output 0 (least significant bit)
Y1	14	18	0	Output 1
Y2	13	17	0	Output 2
Y3	12	15	0	Output 3
Y4	11	14	0	Output 4
Y5	10	13	0	Output 5
Y6	9	12	0	Output 6
Y7	7	9	0	Output 7 (most significant bit)

⁽¹⁾ Signal Types: I = Input, O = Output, I/O = Input or Output.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
I _{IK}	Input clamp current ⁽²⁾	$V_I < 0$ or $V_I > V_{CC}$		±20	mA
I _{OK}	Output clamp current ⁽²⁾	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	$V_O = 0$ to V_{CC}		±25	mA
	Continuous current through V _{CC} or	GND		±50	mA
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device

6.2 ESD Ratings: SN74HC138

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	\/
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±1000	

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

AX UNIT	XAM MC	MIN NOM			
6 V	5 6	2 5		Supply voltage	V _{CC}
		1.5	V _{CC} = 2 V		
V		3.15	V _{CC} = 4.5 V	High-level input voltage	V_{IH}
		4.2	V _{CC} = 6 V		
0.5	0.5		V _{CC} = 2 V		
.35 V	1.35		V _{CC} = 4.5 V	L Low-level input voltage	V_{IL}
1.8	1.8		V _{CC} = 6 V		
/ _{CC} V	V _{CC}	0	·	Input voltage	V _I
/cc V	V _{CC}	0		Output voltage	Vo
000	1000		V _{CC} = 2 V		
500 ns	500		V _{CC} = 4.5 V	Input transition rise or fall time	Δt/Δν
00	400		V _{CC} = 6 V		
pF	85	85	·	Power dissipation capacitance (no load)	C _{pd}
125 °C	125	- 55	SN54HC138	Operating free dir tomperature	т
85	85	-40	SN74HC138	Operating free-all temperature	IΑ
V 10 5 4		0 85 –55	$V_{CC} = 4.5 \text{ V}$ $V_{CC} = 6 \text{ V}$ SN54HC138	Output voltage Input transition rise or fall time	V _O Δt/Δv

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See TI application report, Implications of Slow or Floating CMOS Inputs (SCBA004).

Product Folder Links: SN54HC138 SN74HC138

The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.4 Thermal Information: SN74HC138

		SN74HC138						
	THERMAL METRIC(1)	D (SOIC)	DB (SSOP)	N (PDIP)	NS (SO)	PW (TSSOP)	UNIT	
		16 PINS	16 PINS	16 PINS	16 PINS	16 PINS		
$R_{\theta JA}$	Junction-to-ambient thermal resistance	87.3	104.3	54.8	91.1	141.6	°C/W	
R ₀ JC(top)	Junction-to-case (top) thermal resistance	45.8	54.7	42.1	49.5	49.5	°C/W	
$R_{\theta JB}$	Junction-to-board thermal resistance	44.8	54.9	34.8	51.5	59.6	°C/W	
ΨЈТ	Junction-to-top characterization parameter	14.2	17.7	27	17.8	6.9	°C/W	
ΨЈВ	Junction-to-board characterization parameter	44.5	54.4	34.7	51.2	59.1	°C/W	

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Thermal Information: SN54HC138

	THERMAL METRIC ⁽¹⁾	J (CDIP)	W (CFP)	FK (LCCC)	UNIT
		16 PINS	16 PINS	20 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	_	_	_	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	45.4	68.1	49	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	_	118.4	47.7	°C/W
ΨЈТ	Junction-to-top characterization parameter	_	_	7.2	°C/W
ΨЈВ	Junction-to-board characterization parameter	62.5	_	_	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	17.7	9	_	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

6.6 Electrical Characteristics

T_A = 25°C (unless otherwise noted)

PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
			V _{CC} = 2 V	1.9	1.998		
		$I_{OH} = -20 \mu A$	V _{CC} = 4.5 V	4.4	4.499		
V _{OH}	$V_I = V_{IH}$ or V_{IL}		V _{CC} = 6 V	5.9	5.999		V
		$I_{OH} = -4 \text{ mA}, V_{CC} = 4.$	5 V	3.98	4.3		
		I_{OH} = -5.2 mA, V_{CC} = 0	I _{OH} = -5.2 mA, V _{CC} = 6 V		5.8		
		I_{OL} = 20 μ A	V _{CC} = 2 V		0.002	0.1	
			V _{CC} = 4.5 V		0.001	0.1	
V _{OL}	V _I = V _{IH} or V _{IL}		V _{CC} = 6 V		0.001	0.1	V
		$I_{OL} = 4 \text{ mA}, V_{CC} = 4.5$	V		0.17	0.26	
		I _{OL} = 5.2 mA, V _{CC} = 6 V			0.15	0.26	
I _I	$V_I = V_{CC}$ or 0, $V_{CC} =$	6 V			±0.1	±100	nA
I _{CC}	$V_I = V_{CC}$ or 0, $I_O = 0$, V _{CC} = 6 V				8	μA
Ci	V _{CC} = 2 V to 6 V				3	10	pF

⁽²⁾ $R_{\theta JC}$ follows MIL-STD-883, and $R_{\theta JB}$ follows JESD51.



6.7 Electrical Characteristics: SN74HC138

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
			V _{CC} = 2 V	1.9			
		$I_{OH} = -20 \mu A$	V _{CC} = 4.5 V	4.4			
V _{OH}	$V_I = V_{IH}$ or V_{IL}	$V_{CC} = 6$	V _{CC} = 6 V	5.9			V
		$I_{OH} = -4 \text{ mA}, V_{CC} = 4$.5 V	3.84			
		I_{OH} = -5.2 mA, V_{CC} =	6 V	5.34			
		I _{OL} = 20 μA	V _{CC} = 2 V			0.1	
			V _{CC} = 4.5 V			0.1	
V _{OL}	V _I = V _{IH} or V _{IL}		V _{CC} = 6 V			0.1	V
		$I_{OL} = 4 \text{ mA}, V_{CC} = 4.5$	5 V			0.33	
		$I_{OL} = 5.2 \text{ mA}, V_{CC} = 6$	S V			0.33	
I _I	$V_I = V_{CC}$ or 0, $V_{CC} =$	6 V				±1000	nA
I _{CC}	$V_{I} = V_{CC} \text{ or } 0, I_{O} = 0,$	V _{CC} = 6 V				80	μA
C _i	V _{CC} = 2 V to 6 V					10	pF

6.8 Electrical Characteristics: SN54HC138

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CO	ONDITIONS	V _{cc}	MIN	TYP	MAX	UNIT
			V _{CC} = 2 V	1.9			
		$I_{OH} = -20 \mu A$	V _{CC} = 4.5 V	4.4			
V _{OH}	$V_I = V_{IH}$ or V_{IL}		V _{CC} = 6 V	5.9			V
		$I_{OH} = -4 \text{ mA}, V_{CC} = 4.5 \text{ V}$		3.7			
		I_{OH} = -5.2 mA, V_{CC} = 6 V		5.2			
			V _{CC} = 2 V			0.1	
		I _{OL} = 20 μA	V _{CC} = 4.5 V			0.1	
V _{OL}	V _I = V _{IH} or V _{IL}		V _{CC} = 6 V			0.1	V
		I _{OL} = 4 mA, V _{CC} = 4.5 V				0.4	
		I _{OL} = 5.2 mA, V _{CC} = 6 V				0.4	
I _I	$V_I = V_{CC}$ or 0, $V_{CC} = 6 V$					±1000	nA
I _{CC}	$V_I = V_{CC}$ or 0, $I_O = 0$, V_{CC}	= 6 V				160	μA
Ci	V _{CC} = 2 V to 6 V					10	pF

6.9 Switching Characteristics

 $T_A = 25$ °C and $C_L = 50$ pF (unless otherwise noted; see Section 7)

PARAMETER	TEST CONDITIONS	·	MIN	TYP	MAX	UNIT
		V _{CC} = 2 V		67	180	
	From A, B, or C (input) to any Y (output)	V _{CC} = 4.5 V		18	36	
+ .		V _{CC} = 6 V		15	31	ne
t _{pd}	From enable (input) to any Y (output)	V _{CC} = 2 V		66	155	ns
		V _{CC} = 4.5 V		18	31	
		V _{CC} = 6 V		15	26	
		V _{CC} = 2 V		38	75	
t _t	To any output	V _{CC} = 4.5 V		8	15	ns
		V _{CC} = 6 V		6	13	



6.10 Switching Characteristics: SN74HC138

over recommended operating free-air temperature range and C_L = 50 pF (unless otherwise noted; see Section 7)

PARAMETER	TEST CONDITIONS	TEST CONDITIONS				UNIT
		V _{CC} = 2 V	·		225	
t _{pd}	From A, B, or C (input) to any Y (output)	V _{CC} = 4.5 V				
		V _{CC} = 6 V			38	no
	From enable (input) to any Y (output)	V _{CC} = 2 V			195	ns
		V _{CC} = 4.5 V			39	
		V _{CC} = 6 V	·		33	
		V _{CC} = 2 V				
t _t	To any output	V _{CC} = 4.5 V			19	ns
		V _{CC} = 6 V			16	

6.11 Switching Characteristics: SN54HC138

over recommended operating free-air temperature range and C_L = 50 pF (unless otherwise noted; see Section 7)

PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
t _{pd}		V _{CC} = 2 V			270		
	From A, B, or C (input) to any Y (output)	V _{CC} = 4.5 V			54		
		V _{CC} = 6 V			46	20	
		V _{CC} = 2 V		235	ns		
	From enable (input) to any Y (output)	V _{CC} = 4.5 V			47		
		V _{CC} = 6 V			40		
		V _{CC} = 2 V		110			
t _t	To any output	V _{CC} = 4.5 V	22			ns	
		V _{CC} = 6 V			19		

6.12 Typical Characteristic

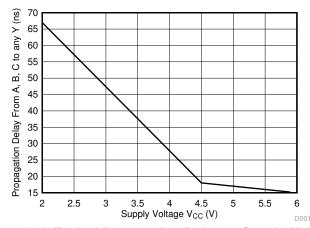
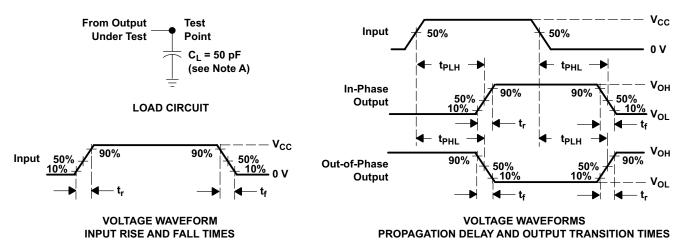


Figure 6-1. Typical Propagation Delay vs Supply Voltage



7 Parameter Measurement Information



NOTES: A. C_L includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r = 6$ ns, $t_f = 6$ ns.
- C. The outputs are measured one at a time with one input transition per measurement.
- D. t_{PLH} and t_{PHL} are the same as t_{pd} .

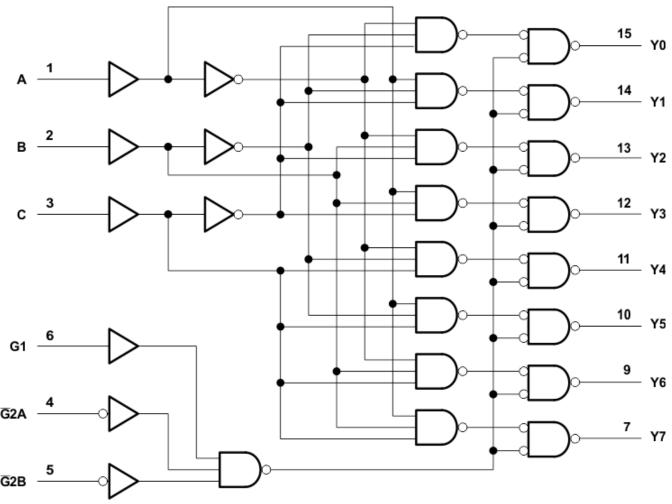
Figure 7-1. Load Circuit and Voltage Waveforms

8 Detailed Description

8.1 Overview

The SNx4HC138 devices are 3-to-8 decoders and demultiplexers. The three input pins, A, B, and C, select which output is active. The selected output is pulled LOW, while the remaining outputs are all HIGH. The conditions at the binary-select inputs at the three enable inputs select one of eight output lines. Two active-low and one active-high enable inputs reduce the requirement for external gates or inverters when expanding. A 24-line decoder can be implemented without external inverters, and a 32-line decoder requires only one inverter. An enable input can be used as a data input for demultiplexing applications.

8.2 Functional Block Diagram



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Pin numbers shown are for the D, DB, J, N, NS, PW, and W packages.

8.3 Feature Description

This device features three binary inputs to select a single active-low output. Three enable pins are also available to enable or disable the outputs. One active high enable and two active low enable pins are available, and any enable pin can be deactivated to force all outputs high. All three enable pins must be active for the output to be enabled.



8.4 Device Functional Modes

Table 8-1 lists the functions of the SNx4HC138 devices.

Table 8-1. Function Table

		INP	UTS						OUTI	эште			
E	ENABL	E		SELECT	Γ				0011	-013			
G1	G2A	G ₂ B	С	В	Α	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
Х	Н	Х	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Х	Х	Н	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
L	Х	X	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
Н	L	L	L	L	L	L	Н	Н	Н	Н	Н	Н	Н
Н	L	L	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н
Н	L	L	L	Н	L	Н	Н	L	Н	Н	Н	Н	Н
Н	L	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н	Н
Н	L	L	Н	L	L	Н	Н	Н	Н	L	Н	Н	Н
Н	L	L	Н	L	Н	Н	Н	Н	Н	Н	L	Н	Н
Н	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н
Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L



9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74HC138 is useful as a scanning column selector for an LED Matrix display as it can be used for the low side drive of the LED string. The decoder functionality ensures that no more than one output is pulled to a low-level logic voltage so that only a single column is enabled at any point in time.

9.2 Typical Application

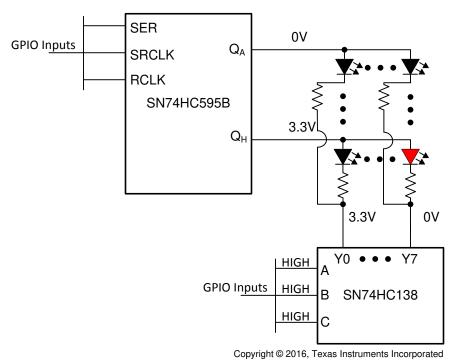


Figure 9-1. LED Matrix Driver Application

9.2.1 Design Requirements

These devices use CMOS technology and have balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive also creates fast edges into light loads, so routing and load conditions must be considered to prevent ringing.

9.2.2 Detailed Design Procedure

- Recommended Input Conditions
 - For switch time specifications, see propagation delay times in Section 6.9.
 - For input voltage level specifications for control inputs, see V_{IH} and V_{IL} in Section 6.6.
- 2. Recommended Output Conditions
 - Outputs must not be pulled above V_{CC} or below GND.

9.2.3 Application Curve

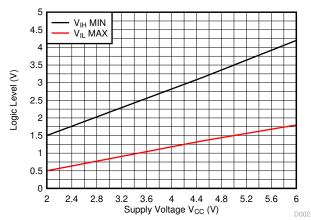


Figure 9-2. Input High and Input Low Thresholds vs Supply Voltage

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the Section 6.3.

Each V_{CC} terminal must have a good bypass capacitor to prevent power disturbance. A 0.1- μ F bypass capacitor is recommended to be placed close to the V_{CC} terminal. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise; 0.1- μ F and 1- μ F capacitors are commonly used in parallel. The bypass capacitor must be installed as close to the power terminal as possible for best results.

11 Layout

11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self–inductance of the trace (resulting in the reflection). It is a given that not all PCB traces can be straight, and so they have to turn corners. Figure 11-1 shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

11.2 Layout Example

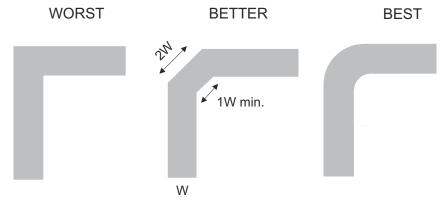


Figure 11-1. Trace Example



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

Implications of Slow or Floating CMOS Inputs (SCBA004)

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 12-1. Related Links

PARTS	PRODUCT FOLDER	PRODUCT FOLDER SAMPLE & BUY		TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54HC138	Click here	Click here	Click here	Click here	Click here	
SN74HC138	Click here	Click here	Click here	Click here	Click here	

12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.5 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

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12.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8406201VEA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8406201VE A SNV54HC138J	Samples
5962-8406201VFA	ACTIVE	CFP	W	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-8406201VF A SNV54HC138W	Samples
84062012A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	84062012A SNJ54HC 138FK	Samples
8406201EA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8406201EA SNJ54HC138J	Samples
8406201FA	ACTIVE	CFP	W	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8406201FA SNJ54HC138W	Samples
JM38510/65802B2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65802B2A	Samples
JM38510/65802BEA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65802BEA	Samples
M38510/65802B2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65802B2A	Samples
M38510/65802BEA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	JM38510/ 65802BEA	Samples
SN54HC138J	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	SN54HC138J	Samples
SN74HC138DBR	ACTIVE	SSOP	DB	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138DR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138DRE4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138DRG4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138N	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC138N	Samples
SN74HC138NE4	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74HC138N	Samples



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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74HC138NSR	ACTIVE	so	NS	16	2000	RoHS & Green	(6) NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SN74HC138PWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HC138	Samples
SNJ54HC138FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	84062012A SNJ54HC 138FK	Samples
SNJ54HC138J	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8406201EA SNJ54HC138J	Samples
SNJ54HC138W	ACTIVE	CFP	W	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	8406201FA SNJ54HC138W	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF SN54HC138, SN54HC138-SP, SN74HC138:

Catalog: SN74HC138, SN54HC138

Automotive: SN74HC138-Q1, SN74HC138-Q1

Military: SN54HC138

Space: SN54HC138-SP

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications
- Space Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC138DBR	SSOP	DB	16	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74HC138DR	SOIC	D	16	2500	330.0	16.4	6.6	9.3	2.1	8.0	16.0	Q1
SN74HC138DRG4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74HC138NSR	so	NS	16	2000	330.0	16.4	8.45	10.55	2.5	12.0	16.2	Q1
SN74HC138NSR	so	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74HC138PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC138PWR	TSSOP	PW	16	2000	330.0	12.4	6.85	5.45	1.6	8.0	12.0	Q1
SN74HC138PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC138PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC138DBR	SSOP	DB	16	2000	356.0	356.0	35.0
SN74HC138DR	SOIC	D	16	2500	366.0	364.0	50.0
SN74HC138DRG4	SOIC	D	16	2500	340.5	336.1	32.0
SN74HC138NSR	SO	NS	16	2000	356.0	356.0	35.0
SN74HC138NSR	SO	NS	16	2000	356.0	356.0	35.0
SN74HC138PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74HC138PWR	TSSOP	PW	16	2000	366.0	364.0	50.0
SN74HC138PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
SN74HC138PWRG4	TSSOP	PW	16	2000	356.0	356.0	35.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-8406201VFA	W	CFP	16	25	506.98	26.16	6220	NA
84062012A	FK	LCCC	20	55	506.98	12.06	2030	NA
8406201FA	W	CFP	16	25	506.98	26.16	6220	NA
JM38510/65802B2A	FK	LCCC	20	55	506.98	12.06	2030	NA
M38510/65802B2A	FK	LCCC	20	55	506.98	12.06	2030	NA
SN74HC138N	N	PDIP	16	25	506	13.97	11230	4.32
SN74HC138N	N	PDIP	16	25	506	13.97	11230	4.32
SN74HC138NE4	N	PDIP	16	25	506	13.97	11230	4.32
SN74HC138NE4	N	PDIP	16	25	506	13.97	11230	4.32
SNJ54HC138FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54HC138W	W	CFP	16	25	506.98	26.16	6220	NA

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



W (R-GDFP-F16)

CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP2-F16



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOF



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOF



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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